

Innovation for Our Energy Future

OPTIMIZING CARBON NANOTUBE CONTACTS FOR USE IN ORGANIC PHOTOVOLTAICS

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Transparent Contacts in PV

- Thin Film Devices
 - CdTe (16.5%) TC sees 600°C
 - CIGS (20%) TC must be grown at room T
- TCOs
 - ZnO:AI, SnO_2 :F, In_2O_3 :Sn, Cd_2SnO_4
- TCs must meet different requirements in each technology
- Successful demonstration of SWNT electrodes in thin film devices



www.nrel.gov/ncpv/thin_film/docs/wc4papernoufi__.doc CIGS - Contreras, J.Phys.Chem. C, 14045, 2007; CdTe - Barnes, APL, 243503, 2007

Carbon Nanotube Basics

Multi-wall tubes



Baughman, Science 287 2002

Single-wall bundle



- Many synthesis methods
 - CVD, Arc, HipCO, laser vaporization
- Extensive postprocessing
- Impurities
- Multi vs. Single Wall
- Random chirality distribution
 - 1/3 metallic, 2/3 semiconducting



Armchair (m)

Zig-zag

Chiral

OPV Device Structures Bulk Heterojunctions



Short diffusions lengths would require impractically thin absorber layers in a "stacked" heterojunction (BHJ ~ 300nm thick)

Mix P3HT and PCBM in a 1:1 ratio to create a "bulk" heterojunction P3HT carries holes to the ITO side, PCBM transports electrons to Al

OPV Device Results: J. van de Lagemaat, T. M. Barnes, G. Rumbles et al., Applied Physics Letters **88** (23), 3 (2006).



Early SWCNT Production at NREL

- All "TCO" work so far uses laser tubes
- 1nm < d < 1.4 nm; all SWCNT
- PLV tubes are very long with low defect density (Raman D/G ~1/190)
- Films formed by vacuum filtration/ membrane transfer



NREL Pulsed Laser Vaporization



Wu, Science. **305**, 1274 (2004)

Scalable Production: Ultra-sonic spray





Metrics: Transparency, Conductivity, Stability

Parameter Matrix Purification: metals, amorphous C Surfactant: SWCNT dispersion, bundle size Sonication: SWCNT length, bundle size, defects Post Processing: surfactant removal, doping Surface Functionalization: wetting, drop formation



. 26.9 nm

1 x 4 inch

Ink Formulation for Ultrasonic Spray



- Aqueous inks
- Ink sonication
- Tube purification/ starting material
- Surfactant choice is key
 - Morphology
 - Conductivity
 - Removal



Sprayed vs. Membrane Transferred





- Large scale roughness in membrane films
- Possible texturing from membrane
- Wrinkling



- Sprayed films are more uniform
- ~70 Ω/sq, 80% T (400-1500 nm)
- Smooth and featureless
 - Potential for fewer shorts in devices
 - Fewer apparent impurities



Compare TCOs with SWCNTs





Conductivity in "Bulk" Networks





Schottky barriers are thought to exist between M and S tubes and limit µ

- Mixture of metallic (1/3) and semiconducting (2/3) tubes
- Tubes/bundles have high aspect ratio in "good" networks
- Measured "p" is low, but networks behave like degenerate semi
- Mobility of the network is very different from individual tubes $\mu_{H, tube} \sim 1000-10000 \text{ cm}^2/\text{V-s}$

 $\begin{array}{l} \mu_{H, \ tube} \thicksim 1000\text{--}10000 \ cm^2/V\text{-s} \\ \mu_{H, \ Network} \thicksim 0.02\text{--}0.1 cm^2/V\text{-s} \end{array}$

Junctions between tubes and bundles dominate conductivity



SWCNT Network Conductivity



Absorption peaks at 650 and 950 are due to fundamental excitonic transitions of SWCNT

- Networks are soaked in HNO₃ after deposition
 - Network consolidation
 - Conductivity
 Improvement
 - $-R_s = 60 \Omega/sq$
- Rinsing after acid
 - Promotes adhesion
 - Improves stability
 - R_s increases to 108 Ω/sq



Devices on NREL SWCNT Networks

- Ultrasonic spray deposition
- Several ~ 3% devices
- Thick active layers spun at 200 rpm
- Reducing electrode
 roughness is key

• PEDOT can be eliminated





Conclusions

- SWCNT networks are the best hole-conducting TC available
 - Enables new device structures using "p" TC
- SWCNT is a good flexible TC
- Optoelectronic performance is improving
 - SWCNT processing, deposition, doping, m/s ratio
- Improve process compatibility for better device performance, new architectures (no PEDOT, invert)
- Device performance likely to improve for sprayed or printed active layers
- SWCNT networks could be a model for new TCs
 - If a completely black material works as a TC, then what else could we use??



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